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| Notice of References Cited | Application/Control No. 10/623,000 | Applicant(s)/Patent Under Reexamination LI, WENZHEN | |
| | Examiner Khanh Tran | Art Unit 2611 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-4,918,393 | 04-1990 | Yokosuka et al. | 329/318 |
| * | B | US-5,903,610 | 05-1999 | Skold et al. | 375/285 |
| * | C | US-5,706,314 | 01-1998 | Davis et al. | 375/340 |
| * | D | US-5,732,109 | 03-1998 | Takahashi, Hidehiro | 375/326 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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